

PowerMOS transistor**BUK451-100A/B****GENERAL DESCRIPTION**

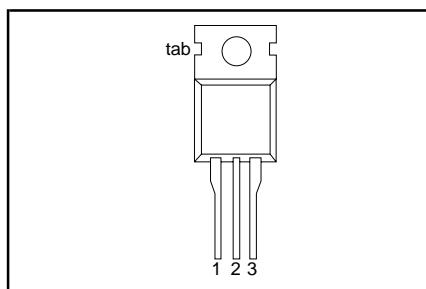
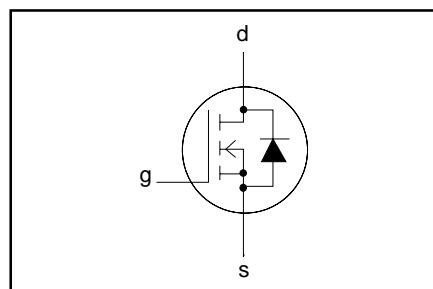
N-channel enhancement mode field-effect power transistor in a plastic envelope.
The device is intended for use in Switched Mode Power Supplies (SMPS), motor control, welding, DC/DC and AC/DC converters, and in general purpose switching applications.

QUICK REFERENCE DATA

SYMBOL	PARAMETER	MAX.	MAX.	UNIT
V_{DS}	BUK451	-100A	-100B	V
I_D	Drain-source voltage	100	100	
P_{tot}	Drain current (DC)	3.0	3.0	A
T_j	Total power dissipation	40	40	W
$R_{DS(ON)}$	Junction temperature	175	175	°C
	Drain-source on-state resistance	0.85	1.1	Ω

PINNING - TO220AB

PIN	DESCRIPTION
1	gate
2	drain
3	source
tab	drain

PIN CONFIGURATION**SYMBOL****LIMITING VALUES**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V_{DS} V_{DGR} $\pm V_{GS}$	Drain-source voltage	$R_{GS} = 20 \text{ k}\Omega$	-	100	V
	Drain-gate voltage		-	100	V
	Gate-source voltage		-	30	V
I_D I_D I_{DM}	Drain current (DC)	$T_{mb} = 25 \text{ }^\circ\text{C}$ $T_{mb} = 100 \text{ }^\circ\text{C}$ $T_{mb} = 25 \text{ }^\circ\text{C}$	-	3.0	A
	Drain current (DC)		-	3.0	A
	Drain current (pulse peak value)		-	12	A
P_{tot} T_{stg} T_j	Total power dissipation	$T_{mb} = 25 \text{ }^\circ\text{C}$	-	40	W
	Storage temperature		-55	175	°C
	Junction Temperature		-	175	°C

PowerMOS transistor**BUK451-100A/B****THERMAL RESISTANCES**

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$R_{th\ j-mb}$	Thermal resistance junction to mounting base		-	-	3.75	K/W
$R_{th\ j-a}$	Thermal resistance junction to ambient		-	60	-	K/W

STATIC CHARACTERISTICS $T_{mb} = 25^\circ C$ unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{(BR)DSS}$	Drain-source breakdown voltage	$V_{GS} = 0 V; I_D = 0.25 \text{ mA}$	100	-	-	V
$V_{GS(TO)}$	Gate threshold voltage	$V_{DS} = V_{GS}; I_D = 1 \text{ mA}$	2.1	3.0	4.0	V
I_{DSS}	Zero gate voltage drain current	$V_{DS} = 100 V; V_{GS} = 0 V; T_j = 25^\circ C$	-	1	10	μA
I_{GSS}	Zero gate voltage drain current	$V_{DS} = 100 V; V_{GS} = 0 V; T_j = 125^\circ C$	-	0.1	1.0	mA
$R_{DS(ON)}$	Gate source leakage current	$V_{GS} = \pm 30 V; V_{DS} = 0 V$	-	10	100	nA
	Drain-source on-state resistance	$V_{GS} = 10 V; I_D = 2.5 A$ BUK451-100A	-	0.75	0.85	Ω
		$V_{GS} = 10 V; I_D = 2.5 A$ BUK451-100B	-	0.90	1.10	Ω

DYNAMIC CHARACTERISTICS $T_{mb} = 25^\circ C$ unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
g_{fs}	Forward transconductance	$V_{DS} = 25 V; I_D = 2.5 A$	1.3	1.7	-	S
C_{iss}	Input capacitance	$V_{GS} = 0 V; V_{DS} = 25 V; f = 1 \text{ MHz}$	-	160	240	pF
C_{oss}	Output capacitance		-	45	60	pF
C_{rss}	Feedback capacitance		-	16	25	pF
$t_{d\ on}$	Turn-on delay time	$V_{DD} = 30 V; I_D = 3 A;$	-	4	6	ns
t_r	Turn-on rise time	$V_{GS} = 10 V; R_{GS} = 50 \Omega;$	-	15	25	ns
$t_{d\ off}$	Turn-off delay time	$R_{gen} = 50 \Omega$	-	10	20	ns
t_f	Turn-off fall time		-	10	20	ns
L_d	Internal drain inductance	Measured from contact screw on tab to centre of die	-	3.5	-	nH
L_d	Internal drain inductance	Measured from drain lead 6 mm from package to centre of die	-	4.5	-	nH
L_s	Internal source inductance	Measured from source lead 6 mm from package to source bond pad	-	7.5	-	nH

REVERSE DIODE LIMITING VALUES AND CHARACTERISTICS $T_{mb} = 25^\circ C$ unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I_{DR}	Continuous reverse drain current	-	-	-	3.0	A
I_{DRM}	Pulsed reverse drain current	-	-	-	12	A
V_{SD}	Diode forward voltage	$I_F = 3.0 A; V_{GS} = 0 V$	-	1.1	1.4	V
t_{rr}	Reverse recovery time	$I_F = 3.0 A; -di_F/dt = 100 A/\mu s;$	-	100	-	ns
Q_{rr}	Reverse recovery charge	$V_{GS} = 0 V; V_R = 30 V$	-	0.25	-	μC

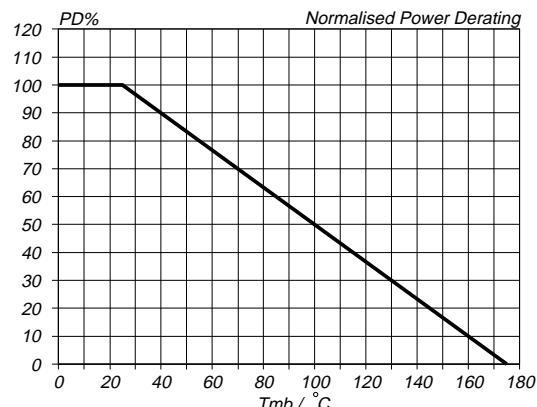
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Fig. 1. Normalised power dissipation.
 $PD\% = 100 \cdot P_D / P_{D\ 25\ ^\circ C} = f(T_{mb})$

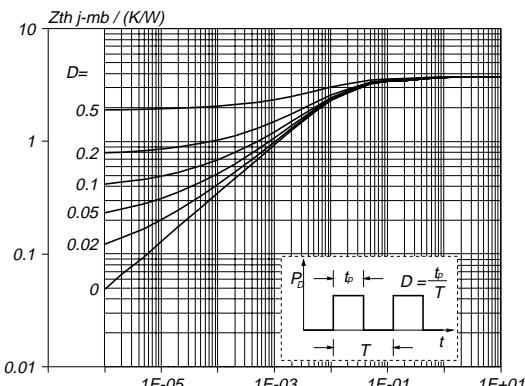


Fig. 4. Transient thermal impedance.
 $Z_{th,j-mb} = f(t); \text{ parameter } D = t_p/T$

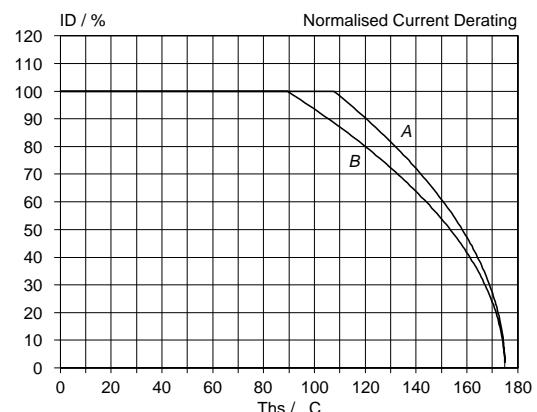


Fig. 2. Normalised continuous drain current.
 $ID\% = 100 \cdot I_D / I_{D\ 25\ ^\circ C} = f(Ths); \text{ conditions: } V_{GS} \geq 5\ V$

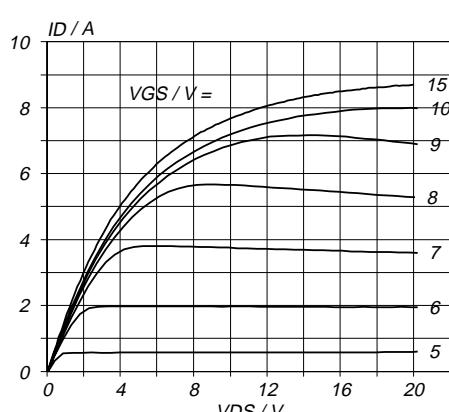


Fig. 5. Typical output characteristics, T_j = 25 °C.
 $I_D = f(V_{DS}); \text{ parameter } V_{GS}$

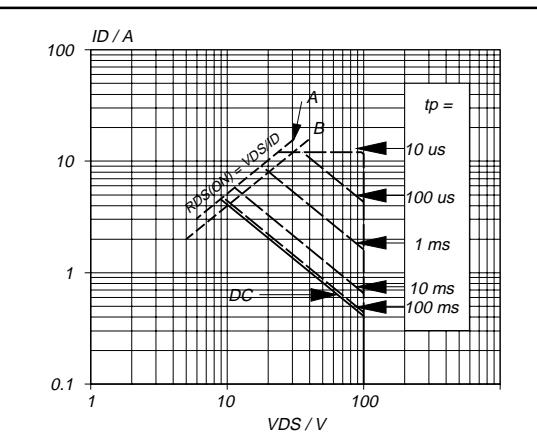


Fig. 3. Safe operating area. T_{mb} = 25 °C
 $I_D \& I_{DM} = f(V_{DS}); I_{DM} \text{ single pulse; parameter } t_p$

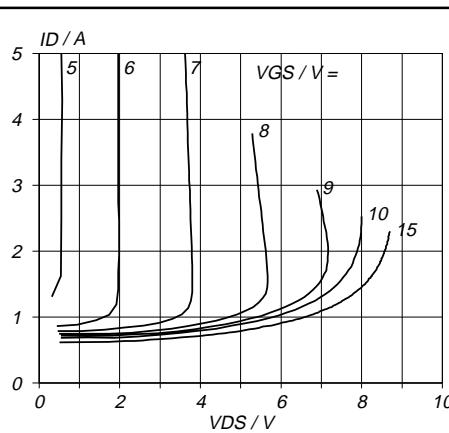


Fig. 6. Typical on-state resistance, T_j = 25 °C.
 $R_{DS(ON)} = f(I_D); \text{ parameter } V_{GS}$

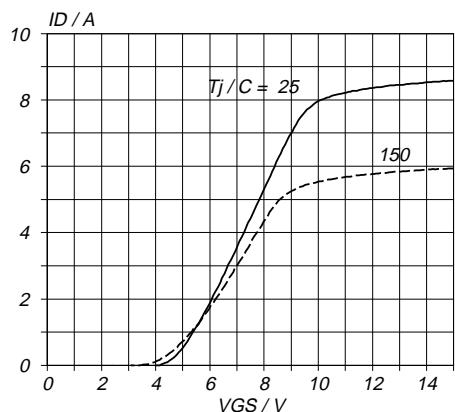
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Fig.7. Typical transfer characteristics.
 $I_D = f(V_{GS})$; conditions: $V_{DS} = 25$ V; parameter T_j

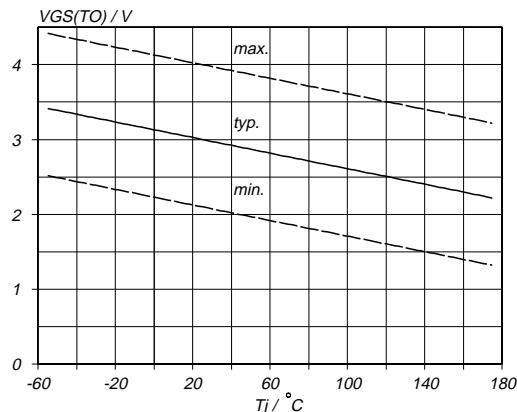


Fig.10. Gate threshold voltage.
 $V_{GS(TO)} = f(T_j)$; conditions: $I_D = 1$ mA; $V_{DS} = V_{GS}$

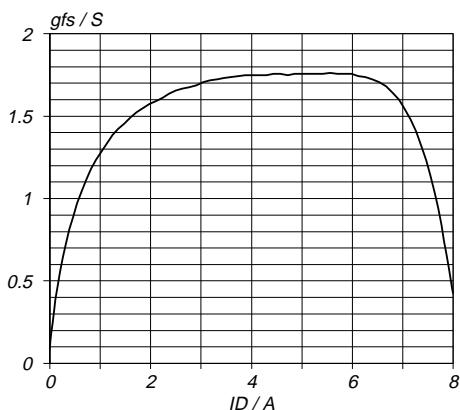


Fig.8. Typical transconductance, $T_j = 25$ °C.
 $g_{fs} = f(I_D)$; conditions: $V_{DS} = 25$ V

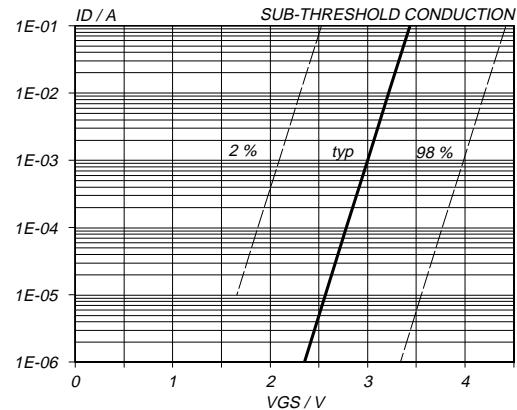


Fig.11. Sub-threshold drain current.
 $I_D = f(V_{GS})$; conditions: $T_j = 25$ °C; $V_{DS} = V_{GS}$

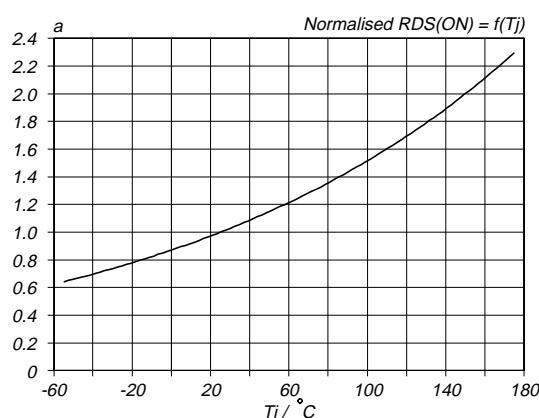


Fig.9. Normalised drain-source on-state resistance.
 $a = R_{DS(ON)}/R_{DS(ON)25\text{ }^{\circ}\text{C}} = f(T_j)$; $I_D = 2.5$ A; $V_{GS} = 5$ V

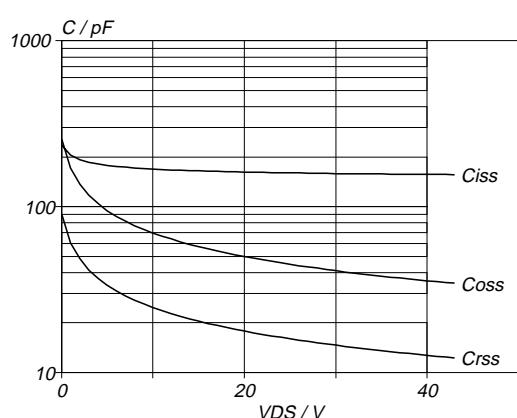


Fig.12. Typical capacitances, C_{iss} , C_{oss} , C_{rss} .
 $C = f(V_{DS})$; conditions: $V_{GS} = 0$ V; $f = 1$ MHz

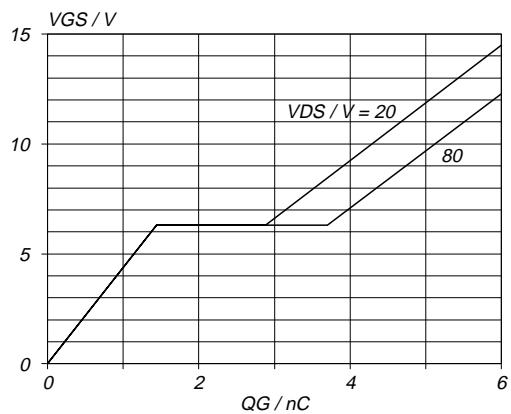
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Fig.13. Typical turn-on gate-charge characteristics.
 $V_{GS} = f(Q_G)$; conditions: $I_D = 3 \text{ A}$; parameter V_{DS}

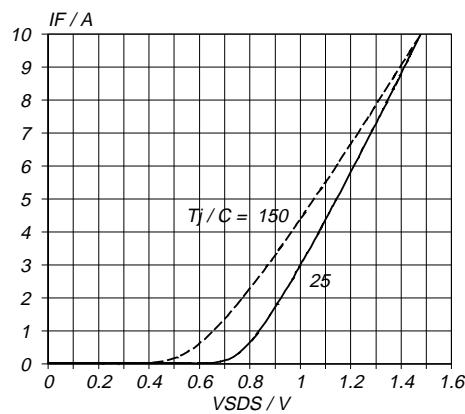


Fig.14. Typical reverse diode current.
 $I_F = f(V_{SDS})$; conditions: $V_{GS} = 0 \text{ V}$; parameter T_j

PowerMOS transistor**BUK451-100A/B****MECHANICAL DATA***Dimensions in mm*

Net Mass: 2 g

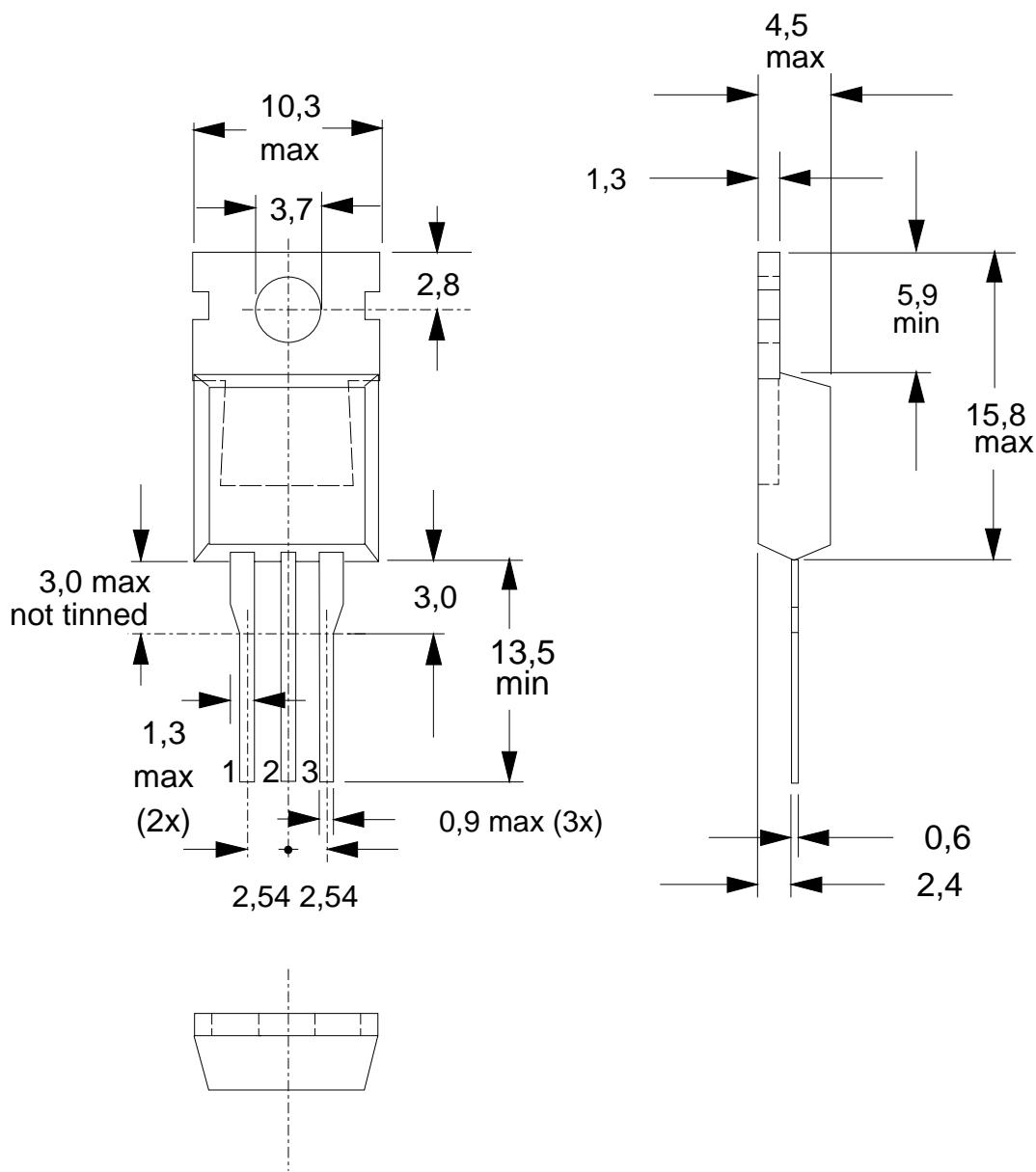


Fig.15. TO220AB; pin 2 connected to mounting base.

Notes

1. Observe the general handling precautions for electrostatic-discharge sensitive devices (ESDs) to prevent damage to MOS gate oxide.
2. Refer to mounting instructions for TO220 envelopes.
3. Epoxy meets UL94 V0 at 1/8".

PowerMOS transistor**BUK451-100A/B****DEFINITIONS**

Data sheet status	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
Limiting values	
Limiting values are given in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of this specification is not implied. Exposure to limiting values for extended periods may affect device reliability.	
Application information	
Where application information is given, it is advisory and does not form part of the specification.	
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